



Edition 2.0 2015-10 REDLINE VERSION

# INTERNATIONAL STANDARD





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# INTERNATIONAL STANDARD



INTERNATIONAL ELECTROTECHNICAL COMMISSION

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## INTERNATIONAL ELECTROTECHNICAL COMMISSION

## FIXED ELECTRIC DOUBLE-LAYER CAPACITORS FOR USE IN ELECTRIC AND ELECTRONIC EQUIPMENT –

## Part 1: Generic specification

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International Standard IEC 62391-1 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment.

This second edition cancels and replaces the first edition published in 2006 and constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) enhancement of the scope to include electric (high power) application;
- b) implementation of Annex Q, replacing Clause 3 in the first edition;
- c) in addition, minor revisions related to tables, figures and references.

The text of this standard is based on the following documents:

FDIS	Report on voting
40/2393/FDIS	40/2415/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of IEC 62391 under the general title Fixed electric double-layer capacitors for use in electric and electronic equipment can be found in the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- · reconfirmed,
- withdrawn,
  - · replaced by a revised edition, or
  - amended.

The contents of the corrigenda of December 2016 and June 2019 have been included in this copy.

A bilingual version of this publication may be issued at a later date.

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## FIXED ELECTRIC DOUBLE-LAYER CAPACITORS FOR USE IN ELECTRIC AND ELECTRONIC EQUIPMENT -

## Part 1: Generic specification

## 1 General

## 1 Scope

This part of IEC 62391 applies to fixed electric double-layer capacitors (hereafter referred to as capacitor(s)) mainly used in d.c. circuits of electric and electronic equipment.

This part of IEC 62391 establishes standard terms, inspection procedures and methods of test for use in sectional and detail specifications of electronic components for quality assessment or any other purpose.

## 2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60027 (all parts), Letter symbols to be used in electrical technology

IEC 60050 (all parts), International Electrotechnical Vocabulary

IEC 60062, Marking codes for resistors and capacitors

IEC 60063, Preferred number series for resistors and capacitors

IEC 60068 1:1088 2013, Environmental testing – Part 1: General and guidance

Amendment 1 (1992)

IEC 60068-2-1: 1990 2007, Environmental testing – Part 2-1: Tests – Tests A: Cold Amendment 1 (1993)

Amendment 2 (1994)

IEC 60068-2-2:<del>1974</del> 2007, Environmental testing – Part 2-2: Tests – Tests B: Dry Heat

Amendment 1 (1993) Amendment 2 (1994)

IEC 60068-2-6:<del>1995</del> 2007, Environmental testing – Part 2-6: Tests – Test Fc: Vibration (sinusoidal)

IEC 60068-2-14:<del>1984</del> 2009, Environmental testing – Part 2-14: Tests – Test N: Change of temperature

Amendment 1 (1986)

IEC 60068-2-20:<del>1979</del> 2008, Environmental testing – Part 2-20: Tests – Test T: Soldering Test methods for solderability and resistance to soldering heat of devices of with leads Amendment 2 (1987)

IEC 60068-2-21:<del>1999</del> 2006, Environmental testing – Part 2-21: Tests – Test U: Robustness of terminations and integral mounting devices

IEC 60068-2-45:1980, Environmental testing – Part 2-45: Tests – Test XA and guidance: Immersion in cleaning solvents
Amendment 1:1993

IEC 60068-2-47:1999, Environmental testing — Part 2-47: Test methods — Mounting of components, equipment and other articles for vibration, impact and similar dynamic tests

IEC 60068-2-54:2006, Environmental testing – Part 2-54: Tests – Test Ta: Solderbility testing of electronic components by the wetting balance method

IEC 60068-2-58:<del>2004</del> 2015, Environmental testing — Part 2-58: Tests — Test Td: Test methods for solderability, resistance to dissolution of metallization and to soldering heat of surface mounting devices (SMD)

IEC 60068-2-69:2007, Environmental testing – Part 2-69: Tests – Test Tex Solderability testing of electronic components for surface mounting devices (SMD) by the wetting balance method

IEC 60068-2-78:2001 2012, Environmental testing Part 2-78: Test Cab: Damp heat, steady state

IEC 60294:1969 2012, Measurement of the dimensions of a cylindrical component having two with axial terminations

IEC 60617 (all parts) [DB], Graphical symbols for diagrams

IEC 60695-11-5, Fire hazard testing — Part 11-5: Test flames — Needle-flame test method — Apparatus, confirmatory test arrangement and guidance

IEC 60717:1981 2012. Method for the determination of the space required by capacitors and resistors with unidirectional terminations

IEC 61193-2. Quality assessment systems – Part 2: Selection and use of sampling plans for inspection of electronic components and packages

IEC 61760-1:1998, Surface mounting technology – Part 1: Standard method for the specification of surface mounting components (SMDs)

QC001002-3, Rules of procedure - Part 3: Approval procedures

ISO 1000:1992, SI units and recommendations for the use of their multiples and of certain other units

<sup>&</sup>lt;sup>1</sup> DB" refers to the IEC on-line database.

### 3 Terms and definitions

For the purposes of this document, the following terms and definitions apply:

### 3.1

## type

group of components having similar design features and the similarity of whose manufacturing techniques, enables enabling them to be grouped considered together, either for qualification approval or for quality conformance inspection; they are generally covered by a single detail specification

Note 1 to entry: In some cases, components described in several detail specifications may be considered as belonging to the same type.

[SOURCE: IEC 60384-1:2008, 2.2.39 – modified, the remark on "single detail specification" was deleted from the definition and the Note was rephrased.]

## 3.2

style

subdivision of a type, generally based on dimensional factors

Note 1 to entry: A style may include several variants, generally of a mechanical order.

## 2.2.3

## grade

term to indicate an additional general characteristic concerning the intended application of the component which may only be used in combination with one or more words (e.g. long life grade) and not by a single letter or number

## 3.3

#### class

classification of the capacitor by the capacitance value and the internal resistance value depending upon the application 1946-65a-483d-9189-4339acbc2ca/iec-62391

## 3.4

## family

<electronic components > group of components which predominantly displays a particular physical attribute and/or fulfils a defined function

## 3.5

## subfamily

<electronic components> group of components within a family manufactured by similar technological methods

### 3.6

## d.c. capacitor

capacitor designed essentially for application with direct voltage

Note 1 to entry: A d.c. capacitor may not be suitable for use on a.c. supplies.

#### 3.7

## rated nominal capacitance

## $C_{\mathbf{R}} C_{\mathbf{N}}$

designated capacitance value usually indicated on the capacitor

#### 3.8

## category temperature range

range of ambient temperatures for which the capacitor has been designed to operate continuously

Note 1 to entry: This is given by the lower and upper category temperature.

#### 3.9

## lower category temperature

minimum ambient temperature for which a capacitor has been designed to operate continuously

#### 3.10

## upper category temperature

maximum highest ambient temperature for including internal heating in which a capacitor has been is designed to operate continuously

[SOURCE: IEC 61881-3:2012, 3.17, modified – The note to entry has been deleted.]

## 3.11

### rated temperature

maximum ambient temperature at which the rated voltage may be continuously applied

#### 3.12

## rated voltage (d.c.)

 $U_{\mathsf{R}}$ 

maximum direct d.c. voltage or peak value of pulse voltage which may be applied continuously or repetitively to a capacitor at any temperature between the lower category temperature and the rated temperature

## 3.13

## category voltage

 $U_{\mathsf{C}}$ 

maximum voltage which may be applied continuously to a capacitor at its upper category temperature

## 3.14

## temperature derated voltage

maximum voltage that may be applied continuously to a capacitor when it is at any temperature between the rated temperature and the upper category temperature

Note 1 to entry: Information on the voltage/temperature dependence at temperatures between the rated temperature and the upper category temperature should, if applicable, be is given in the relevant detail specification.

## 3.15

## surge voltage ratio

quotient of the maximum instantaneous voltage which may be applied to the terminations of the capacitor for a specified time at any temperature within the category temperature range and the rated voltage or the temperature derated voltage, as appropriate

Note 1 to entry: The number of times per hour that this voltage may be applied should be is specified in the detail specification.